



TEST REPORT

Eurofins KCTL Co.,Ltd. 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea TEL: 82-31-285-0894 FAX: 82-505-299-8311 www.kctl.co.kr		Report No.: KR24-SRF0124-A Page (1) of (8)	 
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1. Client

- Name : Samsung Electronics Co., Ltd.
- Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
- Date of Receipt : 2024-07-23

2. Use of Report : Certification

3. Name of Product / Model : Motion Detection Sensor / MDRDI304

4. Manufacturer / Country of Origin : Samsung Electronics Co., Ltd. / Korea

5. FCC ID : A3LMDRDI304

6. IC : 649E-MDRDI304

7. Date of Test : 2024-08-09 to 2024-08-21

8. Location of Test : ☒ Permanent Testing Lab ☐ On Site Testing
 (Address: 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea)

9. Test method used : 47 CRF Part 1.1310
 RSS-102 Issue 6 December 2023

10. Test Result : Refer to the test result in the test report

Affirmation	Tested by		Technical Manager	
	Name : Seongil Choi	(Signature)	Name : Harim Lee	(Signature)

2024-08-26

Eurofins KCTL Co.,Ltd.

As a test result of the sample which was submitted from the client, this report does not guarantee the whole product quality. This test report should not be used and copied without a written agreement by Eurofins KCTL Co.,Ltd.

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REPORT REVISION HISTORY

Date	Revision	Page No
2024-08-22	Originally issued	-
2024-08-26	Revised	4, 5, 6, 7, 9

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Note. The report No. KR24-SRF0124 is superseded by the report No. KR24-SRF0124-A.

General remarks for test reports

Statement concerning the uncertainty of the measurement systems used for the tests

(may be required by the product standard or client)

☐ Internal procedure used for type testing through which traceability of the measuring uncertainty has been established:

Procedure number, issue date and title:

Calculations leading to the reported values are on file with the testing laboratory that conducted the testing.

☒ Statement not required by the standard or client used for type testing

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1. General information

Client : Samsung Electronics Co., Ltd.
 Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
 Manufacturer : Samsung Electronics Co., Ltd.
 Address : 129, Samsung-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Rep. of Korea
 Factory 1 : CHEMTRONICS CO., LTD.
 Address 1 : 35, Buk-ri, Namsa-myeon, Cheoin-gu, Yongin-si, Gyeonggi-do, Korea
 Factory 2 : CHEMTROVINA COMPANY LIMITED
 Address 2 : Nhon Trach 2 - Loc Khang IZ, Hiep Phuoc Town, Nhon Trach District,, Dong Nai Province, Vietnam
 Laboratory : Eurofins KCTL Co.,Ltd.
 Address : 65, Sinwon-ro, Yeongtong-gu, Suwon-si, Gyeonggi-do, 16677, Korea
 Accreditations : FCC Site Designation No: KR0040, FCC Site Registration No: 687132
 VCCI Registration No. : R-20080, G-20078, C-20059, T-20056
 CAB Identifier: KR0040
 ISED Number: 8035A
 KOLAS No.: KT231

2. Device information

Equipment under test : Motion Detection Sensor
 Model : MDRDI304
 Modulation technique : Pulsed-CW
 Frequency range : 61 000 MHz ~ 61 500 MHz
 Power source : DC 3.3 V
 Antenna specification : Patch type antenna
 Antenna gain : 6 dBi
 Operation temperature : -10 °C ~ 80 °C
 Test device serial No. : 037

2.1. Frequency/channel operations

This device contains the following capabilities:

Pulsed-CW

Ch.	Frequency (GHz)
01	61.0 ~ 61.5

Table 2.1.1. Pulsed-CW

2.2. RF power setting in TEST SW

Test condition	Test Program	Frequency (GHz)	Power Setting
Pulsed-CW	N/A	61.25	Default

3. RF Exposure

FCC

Regulation

This document is prepared to show compliance with the RF Exposure requirements as required in §1.1310 of the FCC rules and Regulations.

The limit for Maximum Permissible Exposure (MPE), specified in FCC §1.1310, is listed in Table 1-1. According to FCC §1.1310: the criteria listed in the following table shall be used to evaluate the environmental impact of human exposure to radio-frequency (RF) radiation as specified in §1.1307(b).

Table 1 – Limits for Maximum Permissible Exposure (MPE)

Frequency Range (MHz)	Electric Field Strength [V/m]	Magnetic Field Strength [A/m]	Power Density [mW/cm ²]	Averaging Time [minute]
(A) Limits for Occupational / Controlled Exposure				
0.3 ~ 3.0	614	1.63	*100	6
3.0 ~ 30	1842/f	4.89/f	*900/f ²	6
30 ~ 300	61.4	0.163	1.0	6
300 ~ 1 500	/	/	f/300	6
1 500 ~ 15 000	/	/	5	6
(B) Limits for General Population / Uncontrolled Exposure				
0.3 ~ 1.34	614	1.63	*100	30
1.34 ~ 30	824/f	2.19/f	*180/f ²	30
30 ~ 300	27.5	0.073	0.2	30
300 ~ 1 500	/	/	f/1 500	30
1 500 ~ 15 000	/	/	1.0	30

f=frequency in MHz, * = plane-wave equivalent power density

Per the guidance of KDB 680106, the E-field and H-field limits shown in the table above are extended down to 100 kHz

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IC

Field reference level exposure exemption limits – RF Exposure Evaluation

According to RSS-102 Issue 6 section 6.6, Field reference level (FRL) exposure evaluation is required if the separation distance between the user and/or bystander and the device's radiating element is greater than 20 cm (i.e. mobile devices), except when the device operates as follows:

- Below 20 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 1W (adjusted for tune-up tolerance);
- At or above 20 MHz and below 48 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $4.49/f^{0.5}$ W (adjusted for tune-up tolerance), where f is in MHz;
- At or above 48 MHz and below 300 MHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 0.6 W (adjusted for tune-up tolerance);
- At or above 300 MHz and below 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than $1.31 \times 10^{-2} f^{0.6834}$ W (adjusted for tune-up tolerance), where f is in MHz;
- At or above 6 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance.)

In these cases, the information contained in the RF exposure technical brief may be limited to information that demonstrates how the e.i.r.p. was derived.

3.1. Test results

FCC

MPE (Maximum Permissible Exposure) Prediction

Predication of MPE limit at a given distance: Equation from page 18 of OET Bulletin 65, Edition 97-01

$$S = PG/4\pi R^2 \quad (\Rightarrow R = \sqrt{PG/4\pi S})$$

S = power density [mW/cm^2]

P = Power input to antenna [mW]

G = Power gain of the antenna in the direction of interest relative to an isotropic radiator

R = distance to the center of radiation of the antenna [cm]

IC

RF Exposure evaluation

At or above 15 GHz and below 150 GHz and the source-based, time-averaged maximum e.i.r.p. of the device is equal to or less than 5 W (adjusted for tune-up tolerance)

Calculation Result of RF exposure (FCC)

Maximum tune-up tolerance (Worst Case)

Mode	Frequency [MHz]	Max Tune-up Power [dBm]	Max Tune-up Power [mW]	Ant Gain [dBi]	Power density at 20 cm [mW/cm ²]	Limit [mW/cm ²]
Pulse	61 000 ~ 61 500	8.00	6.31	6.00	0.005	1.00

Calculation Results of RF exposure (IC)

Maximum tune-up tolerance (Worst Case)

Mode	Frequency [MHz]	Max Tune-up Power [dBm]	Ant Gain [dBi]	Calculated EIRP from the max tune-up [dBm]	Maximum EIRP (mW)	Limit [mW]
Pulse	61 000 ~ 61 500	8.00	6.00	14.00	25.12	5 000

End of test report